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ON Semiconductor®

## FDS6675

# Single P-Channel, Logic Level, PowerTrench™ MOSFET

#### **General Description**

This P-Channel Logic Level MOSFET is produced using ON Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

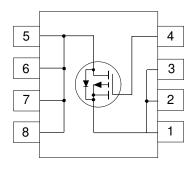
These devices are well suited for notebook computer applications: load switching and power management, battery charging circuits, and DC/DC conversion.

#### **Features**

- Low gate charge (30nC typical).
- High performance trench technology for extremely low RDS(CAN).
- High power and current handling capability.







### **Absolute Maximum Ratings**

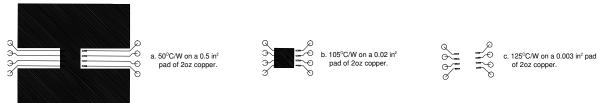
 $T_A = 25^{\circ}C$  unless otherwise noted

Symbol	Parameter		FDS6675	Units		
V <sub>DSS</sub>	Drain-Source Voltage		-30			
V <sub>GSS</sub>	Gate-Source Voltage		±20	V		
D	Drain Current - Continuous	(Note 1a)	-11	А		
	- Pulsed		-50			
$P_{D}$	Power Dissipation for Single Operation	(Note 1a)	2.5	W		
		(Note 1b)	1.2			
		(Note 1c)	1			
J,T <sub>STG</sub>	Operating and Storage Temperature Rang	je	-55 to 150	.€		
THERMA	L CHARACTERISTICS	•		•		
R <sub>eJA</sub>	Thermal Resistance, Junction-to-Ambient	(Note 1a)	50	°C/W		
R <sub>euc</sub>	Thermal Resistance, Junction-to-Case	(Note 1)	25	°C/W		

Symbol	Parameter	Min	Тур	Max	Units	
OFF CHAI	RACTERISTICS					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \ I_D = -250 \ \mu\text{A}$	-30			V
$\Delta BV_{DSS}/\Delta T_{C}$	Breakdown Voltage Temp. Coefficient	$I_D = -250 \mu\text{A}$ , Referenced to 25	°C	-22		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = -24 \text{ V}, \ V_{GS} = 0 \text{ V}$			-1	μΑ
		T <sub>J</sub> =	= 55°C		-10	μΑ
I <sub>GSSF</sub>	Gate - Body Leakage, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
I <sub>GSSR</sub>	Gate - Body Leakage, Reverse	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
ON CHAR	ACTERISTICS (Note 2)	•				•
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	-1	-1.7	-3	V
$\Delta V_{GS(th)}/\Delta T_{J}$	Gate Threshold Voltage Temp. Coefficient	$I_D = 250 \mu\text{A}$ , Referenced to 25 °	°C	4.3		mV/°C
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS} = -10 \text{ V}, I_D = -11 \text{ A}$		0.011	0.014	Ω
		T <sub>J</sub> =	=125°C	0.016	0.023	
		$V_{GS} = -4.5 \text{ V}, I_D = -9 \text{ A}$		0.015	0.02	
I <sub>D(ON)</sub>	On-State Drain Current	$V_{GS} = -10 \text{ V}, \ V_{DS} = -5 \text{ V}$	-50			Α
g <sub>FS</sub>	Forward Transconductance	$V_{DS} = -10 \text{ V}, I_{D} = -11 \text{ A}$		32		S
DYNAMIC	CHARACTERISTICS					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = -15 \text{ V}, \ V_{GS} = 0 \text{ V},$		3000		pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz		870		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			360		pF
SWITCHIN	G CHARACTERISTICS (Note 2)					
t <sub>D(on)</sub>	Turn - On Delay Time	$V_{DS} = -15 \text{ V}, I_{D} = -1 \text{ A}$		12	22	ns
t,	Turn - On Rise Time	$V_{\text{GEN}}$ = -10 V, $R_{\text{GEN}}$ = 6 $\Omega$		16	27	ns
$t_{D(off)}$	Turn - Off Delay Time			50	80	ns
t <sub>f</sub>	Turn - Off Fall Time			100	140	ns
$Q_g$	Total Gate Charge	$V_{DS} = -15 \text{ V}, I_{D} = -11 \text{ A},$		30	42	nC
$Q_{gs}$	Gate-Source Charge	V <sub>GS</sub> = -5 V		9		nC
$Q_{gd}$	Gate-Drain Charge			11		nC
DRAIN-SO	URCE DIODE CHARACTERISTICS AND MA	XIMUM RATINGS	•			
l <sub>s</sub>	Maximum Continuous Drain-Source Diode Fo	orward Current			-2.1	Α
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = -2.1 \text{ A} \text{ (Note 2)}$		-0.72	-1.2	٧

#### Notes:

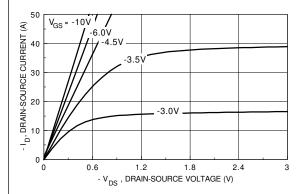
<sup>1.</sup>  $R_{g_{BA}}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{g_{CA}}$  is guaranteed by design while  $R_{g_{CA}}$  is determined by the user's board design.



Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width  $\underline{<}\ 300\mu s,\ Duty\ Cycle \underline{<}\ 2.0\%.$ 

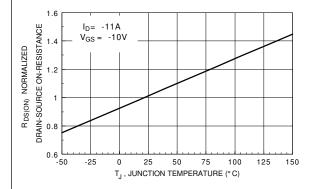
## **Typical Electrical Characteristics**



2.5 QBWALZED QBOONDOO H 2000 1.5 10 20 30 40 50 -1 D DRAIN CURRENT (A)

Figure 1. On-Region Characteristics.

Figure 2. On-Resistance Variation with Dain Current and Gate Voltage.



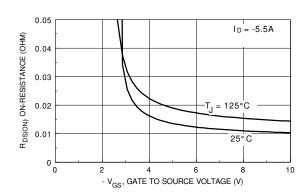
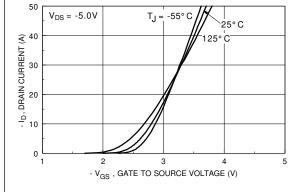


Figure 3. On-Resistance Variation with Temperature.

Figure 4. On-Resistance Variation with Gate-to-Source Voltage.



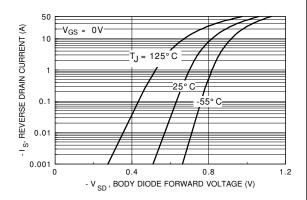
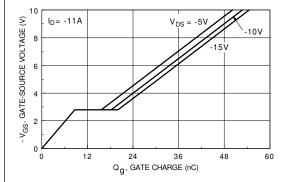


Figure 5. Transfer Characteristics.

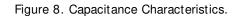
Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

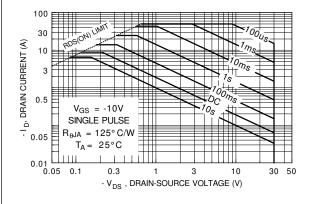
## **Typical Electrical Characteristics** (continued)



6000 4000 2000 BOND 1000 2000 Ciss Coss Crss Crss VGS = 0 V 1000 0.1 0.2 0.5 1 2 5 10 20 30 - V<sub>DS</sub> , DRAIN TO SOURCE VOLTAGE (V)

Figure 7. Gate Charge Characteristics.





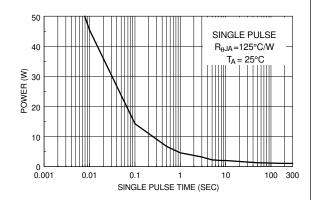
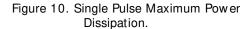


Figure 9. Maximum Safe Operating Area.



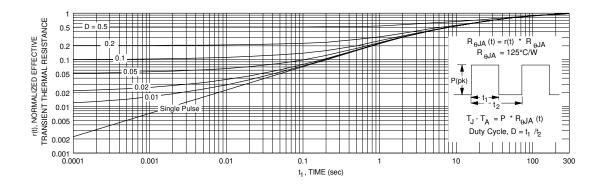
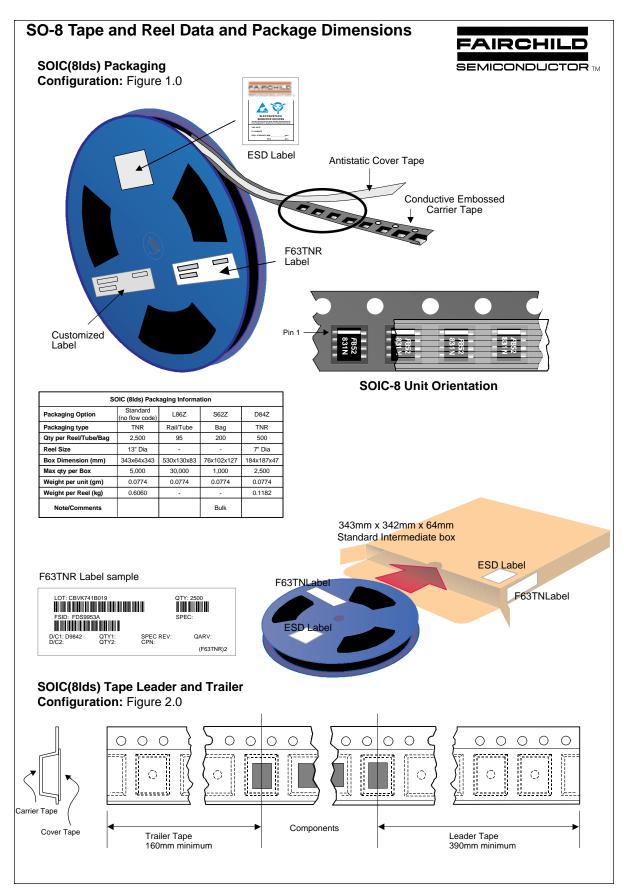


Figure 11. Transient Thermal Response Curve.

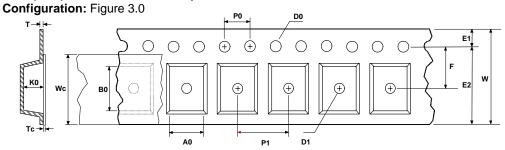
Thermal characterization performed using the conditions described in Note 1c.

Transient thermal response will change depending on the circuit board design.



# SO-8 Tape and Reel Data and Package Dimensions, continued

## SOIC(8lds) Embossed Carrier Tape



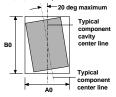


Dimensions are in millimeter														
Pkg type	Α0	В0	w	D0	D1	E1	E2	F	P1	P0	K0	т	Wc	Тс
SOIC(8lds) (12mm)	6.50 +/-0.10	5.30 +/-0.10	12.0 +/-0.3	1.55 +/-0.05	1.60 +/-0.10	1.75 +/-0.10	10.25 min	5.50 +/-0.05	8.0 +/-0.1	4.0 +/-0.1	2.1 +/-0.10	0.450 +/- 0.150	9.2 +/-0.3	0.06 +/-0.02

Notes: A0, B0, and K0 dimensions are determined with respect to the EIA/Jedec RS-481 rotational and lateral movement requirements (see sketches A, B, and C).



Sketch A (Side or Front Sectional View)
Component Rotation



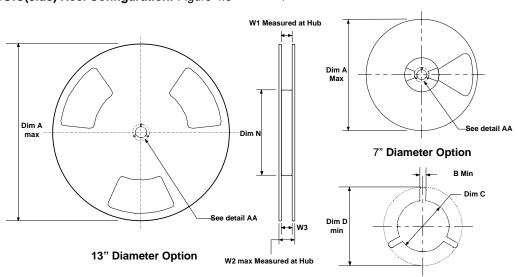
Sketch B (Top View)
Component Rotation



Sketch C (Top View)

Component lateral movement

## SOIC(8lds) Reel Configuration: Figure 4.0

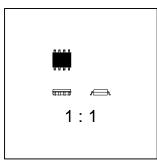


		DETAIL AA									
	Dimensions are in inches and millimeters										
Tape Size	Reel Option			Dim W2	Dim W3 (LSL-USL)						
12mm	7" Dia	7.00 177.8	0.059 1.5	512 +0.020/-0.008 13 +0.5/-0.2	0.795 20.2	5.906 150	0.488 +0.078/-0.000 12.4 +2/0	0.724 18.4	0.469 - 0.606 11.9 - 15.4		
12mm	13" Dia	13.00 330	0.059 1.5	512 +0.020/-0.008 13 +0.5/-0.2	0.795 20.2	7.00 178	0.488 +0.078/-0.000 12.4 +2/0	0.724 18.4	0.469 - 0.606 11.9 - 15.4		

# SO-8 Tape and Reel Data and Package Dimensions, continued

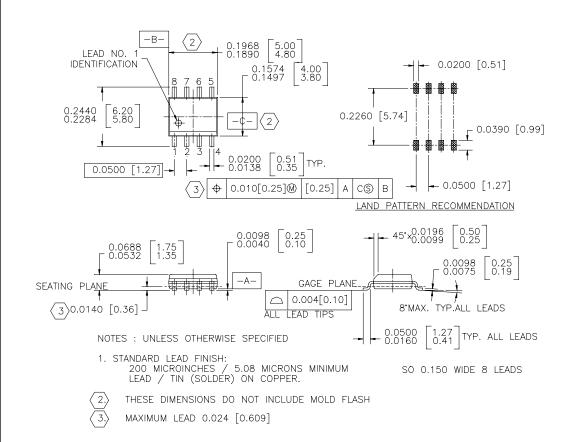
# SOIC-8 (FS PKG Code S1)





Scale 1:1 on letter size paper
Dimensions shown below are in:
inches [millimeters]

Part Weight per unit (gram): 0.0774



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